


<b>Search Notes</b> 	<b>Application/Control No.</b> 10695396	<b>Applicant(s)/Patent Under Reexamination</b> KIM ET AL.
	<b>Examiner</b> DAVID Y CHUNG	<b>Art Unit</b> 2871

SEARCHED			
Class	Subclass	Date	Examiner
349	38,39,141	4/16/07	/D.C./
345	87-103	4/16/07	/D.C./

SEARCH NOTES			
Search Notes		Date	Examiner
EAST search report		4/30/07	/D.C./
EAST search report		4/16/08	/D.C./
EAST search report		11/13/08	/D.C./

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
same	same	6/8/09	/D.C./

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